

**Notice of References Cited**

Application/Control No.

10/042,358

Applicant(s)/Patent Under

Reexamination

ONG ET AL.

Examiner

Erik Kielin

Art Unit

2813

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,069,823	12-1991	Sato et al.	252/500
	B	US-5,347,144	09-1994	Garnier et al.	257/40
	C	US-6,242,561 B1	06-2001	Mohwald et al.	528/377
	D	US-6,320,200 B1	11-2001	Reed et al.	257/40
	E	US-6,445,126 B1	09-2002	Arai et al.	313/504
	F	US-2002/0053320 A1	05-2002	DUTHALER et al.	118/249
	G	US-2002/0053666 A1	05-2002	Marks et al.	257/40
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 97/32914 A1	09-1997	WIPO	Mohwald et al.	--
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.